

# INSULATED GATE BIPOLAR TRANSISTOR

$$V_{CES} = 1200V$$

$$I_{C(Nominal)} = 15A$$

$$T_{J(max)} = 175^{\circ}C$$

$$V_{CE(on)} typ = 1.9V @ I_{C} = 15A$$

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# **Applications**

- Medium Power Drives
- UPS
- HEV Inverter
- Welding

G	С	E
Gate	Collector	Emitter

Features	→ Benefits		
Low V <sub>CE(ON)</sub> and switching losses	High efficiency in a wide range of applications		
LOW VCE(ON) and Switching losses	and switching frequencies		
Square DDCOA and Maximum Junation Temperature 175°C	Improved reliability due to rugged hard switching		
Square RBSOA and Maximum Junction Temperature 175°C	performance and higher power capability		
Positive V <sub>CE (ON)</sub> Temperature Coefficient	Excellent current sharing in parallel operation		

Base part number	Package Type	Standard Pack		Orderable part number
		Form	Quantity	
IRG7CH37K10EF	Die on Film	Wafer	1	IRG7CH37K10EF

## **Mechanical Parameter**

Die Size	4.763 x 4.763	mm <sup>2</sup>		
Minimum Street Width	75	μm		
Emiter Pad Size (Included Gate Pad)	See Die Drawing	mm <sup>2</sup>		
Gate Pad Size	1.0053 x 0.7035			
Area Total / Active	22.69 / 12			
Thickness	140	μm		
Wafer Size	200	mm		
Notch Position	0	Degrees		
Maximum-Possible Chips per Wafer	1206 pcs.			
Passivation Front side	Silicon Nitride			
Front Metal	Al, Si (4μm)			
Backside Metal	Al (1kA°), Ti (1kA°), Ni (4kA°), Ag (6kA°)			
Die Bond	Electrically conductive epoxy or solder			
Reject Ink Dot Size	0.25 mm diameter minimum			



# **Maximum Ratings**

	Parameter	Max.	Units
$V_{CE}$	Collector-Emitter Voltage, T <sub>J</sub> =25°C	1200	V
Ic	DC Collector Current	①	Α
$I_{LM}$	Clamped Inductive Load Current @	60	Α
$V_{\sf GE}$	Gate Emitter Voltage	± 30	V
$T_J$ , $T_{STG}$	Operating Junction and Storage Temperature	-40 to +175	°C

# Static Characteristics (Tested on wafers) @ T<sub>J</sub>=25°C

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)CES</sub>	Collector-to-Emitter Breakdown Voltage	1200			V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA ⑤
V <sub>CE(sat)</sub>	Collector-to-Emitter Saturated Voltage		1.9	2.3		$V_{GE} = 15V, I_{C} = 10A, T_{J} = 25^{\circ}C$
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	5.0		7.5		$I_C = 720\mu A$ , $V_{GE} = V_{CE}$
I <sub>CES</sub>	Zero Gate Voltage Collector Current		1.0	25	μA	V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V
$I_{GES}$	Gate Emitter Leakage Current			±100	nA	$V_{CE} = 0V, V_{GE} = \pm 30V$

Electrical Characteristics (Not subject to production test-verified by design/characterization)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>CE(sat)</sub>	Collector-to-Emitter Saturated Voltage		1.9	2.3	V	$V_{GE} = 15V, I_{C} = 15A, T_{J} = 25^{\circ}C$
			2.5			$V_{GE} = 15V, I_{C} = 15A, T_{J} = 175^{\circ}C$
SCSOA	Short Circuit Safe Operating Area	10				V <sub>GE</sub> = 15V, V <sub>CC</sub> = 600V ②
						$R_G = 10\Omega, V_P \le 1200V, T_J \le 150^{\circ}C$
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE			$T_J = 175^{\circ}C, I_C = 60A$	
						$V_{CC} = 960V, Vp \le 1200V$
						Rg = $10\Omega$ , $V_{GE}$ = +20V to 0V
C <sub>iss</sub>	Input Capacitance		1950		pF	V <sub>GE</sub> = 0V
Coss	Output Capacitance		77			V <sub>CE</sub> = 30V
C <sub>rss</sub>	Reverse Transfer Capacitance		46			f = 1.0MHz
$Q_g$	Total Gate Charge (turn-on)	_	80	_	nC	I <sub>C</sub> = 100A ⑥
$\overline{Q_ge}$	Gate-to-Emitter Charge (turn-on)	_	21	_		V <sub>GE</sub> = 15V
$\overline{Q_gc}$	Gate-to-Collector Charge (turn-on)	—	38	_		V <sub>CC</sub> = 600V

## Switching Characteristics (Inductive Load-Not subject to production test-verified by design/characterization)

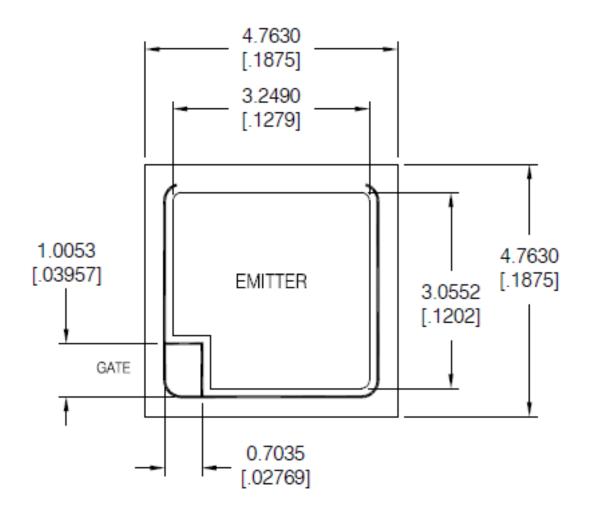
	Parameter	Min.	Тур.	Max.	Units	Conditions 3
$t_{d(on)}$	Turn-On delay time	_	28	_		I <sub>C</sub> = 15A, V <sub>CC</sub> = 600V
t <sub>r</sub>	Rise time	—	27	_		$R_G = 10\Omega, V_{GE} = 15V, L = 260\mu H$
$t_{d(off)}$	Turn-Off delay time		122	_		$T_J = 25^{\circ}C$
t <sub>f</sub>	Fall time	_	105	_		
t <sub>d(on)</sub>	Turn-On delay time	_	26	_	ns	I <sub>C</sub> = 15A, V <sub>CC</sub> = 600V
t <sub>r</sub>	Rise time	-	26	_		$R_G = 10\Omega$ , $V_{GE} = 15V$ , $L = 260\mu H$
$t_{d(off)}$	Turn-Off delay time	_	154	_		T <sub>J</sub> = 175°C
t <sub>f</sub>	Fall time		272	_		

### Notes

- ① The current in the application is limited by T<sub>JMax</sub> and the thermal properties of the assembly.
- ② Not subject to production test-verified by design / characterization.
- ③ Values influenced by parasitic L and C in measurement.
- $\circ$  Refer to AN-1086 for guidelines for measuring  $V_{(BR)CES}$  safely.
- © Die level characterization.



# Die Drawing



# NOTES:

- 1. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 2. CONTROLLING DIMENSION: INCHES
- 3. DIE WIDTH AND LENGTH TOLERANCE: -0.0508 [.002]
- 4. DIE THICKNESS = 0.140 [.0055]

REFERENCE: IRG7CH37K10B



# Additional Testing and Screening

For Customers requiring product supplied as Known Good Die (KGD) or requiring specific die level testing, please contact your local IR Sales

## Shipping

Sawn Wafer on Film. Please contact your local IR sales office for non-standard shipping options

## Handling

- Product must be handled only at ESD safe workstations. Standard ESD precautions and safe work environments are as defined in MIL-HDBK-263.
- Product must be handled only in a class 10,000 or better-designated clean room environment.
- Singulated die are not to be handled with tweezers. A vacuum wand with a non-metallic ESD protected tip should be used.

# Wafer/Die Storage

- Proper storage conditions are necessary to prevent product contamination and/or degradation after shipment.
- Note: To reduce the risk of contamination or degradation, it is recommended that product not being used in the
  assembly process be returned to their original containers and resealed with a vacuum seal process.
- Sawn wafers on a film frame are intended for immediate use and have a limited shelf life.

### **Further Information**

For further information please contact your local IR Sales office or email your inquiry to http://die.irf.com



IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA To contact International Rectifier, please visit <a href="http://www.irf.com/whoto-call/">http://www.irf.com/whoto-call/</a>

单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)